


<div>Search Notes</div> <div></div>	Application/Control N .	Applicant(s)/Patent und r R xamination	
	10/604,350	DEWANJEE, PIJUSH K.	
	Examin r	Art Unit	
	David Buttner	1712	

SEARCHED			
Class	Subclass	Date	Examiner
528	63	1/6/2005	DB
528	64	1/6/2005	DB
528	76	1/6/2005	DB
473	372	1/6/2005	DB
473	373	1/6/2005	DB
473	374	1/6/2005	DB
473	378	1/6/2005	DB

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
chem ab	1/6/2005	DB
east	1/6/2005	DB